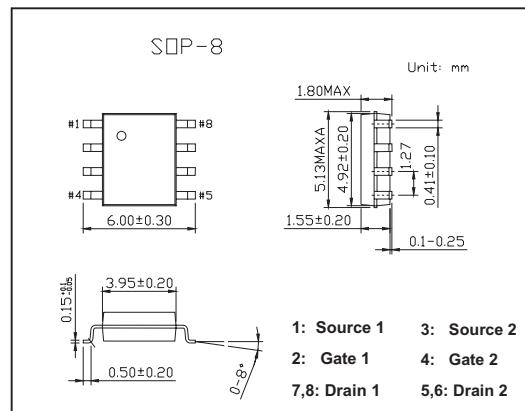
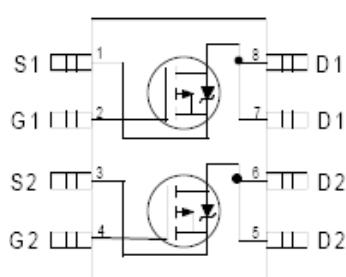


HEXFET® Power MOSFET

KRF7104

■ Features

- Advanced Process Technology
 - Ultra Low On-Resistance
 - Dual P-Channel MOSFET
 - Surface Mount
 - Available in Tape & Reel
 - Dynamic dv/dt Rating
 - Fast Switching



■ Absolute Maximum Ratings $T_a = 25^\circ\text{C}$

Parameter	Symbol	Rating	Unit
Continuous Drain Current, V _{GS} @ 10V @ T _A = 25°C	I _D	-2.3	A
Continuous Drain Current, V _{GS} @ 10V @ T _A = 70°C	I _D	-1.8	
Pulsed Drain Current *1	I _{DM}	-10	
Power Dissipation @T _C = 25°C	P _D	2.0	W
Linear Derating Factor		0.016	W/°C
Gate-to-Source Voltage	V _{GS}	±12	V
Peak Diode Recovery dv/dt *3	dv/dt	-3	V/nS
Junction and Storage Temperature Range	T _J , T _{STG}	-55 to + 150	°C
Maximum Junction-to-Ambient *2	R _{θ JA}	62.5	°C/W

*1 Repetitive rating; pulse width limited by max. junction temperature.

*2 Surface mounted on FR-4 board, $t \leq 10\text{sec}$.

*3 $I_{SD} \leq -2.3A$, $dI/dt \leq 100A/\mu s$, $V_{DD} \leq V_{(BR)DSS}$, $T_J \leq 150^\circ C$

KRF7104

■ Electrical Characteristics Ta = 25°C

Parameter	Symbol	Testconditons	Min	Typ	Max	Unit
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0V, I _D = -250 μ A	-20			V
Breakdown Voltage Temp. Coefficient	△V _{(BR)DSS} /△T _J	I _D = -1mA, Reference to 25°C		-0.015		V/°C
Static Drain-to-Source On-Resistance	R _{D(on)}	V _{GS} = -10V, I _D = -1.0A*1		0.19	0.25	Ω
		V _{GS} = -4.5V, I _D = -0.50A*1		0.30	0.40	
Gate Threshold Voltage	V _{GS(th)}	V _{Ds} = V _{GS} , I _D = -250 μ A	-1.0		-3.0	V
Forward Transconductance	g _f	V _{Ds} = -15V, I _D = -2.3A*1		2.5		S
Drain-to-Source Leakage Current	I _{DSS}	V _{Ds} = -16V, V _{GS} = 0V			-2.0	μ A
		V _{Ds} = -16V, V _{GS} = 0V, T _J = 55°C			-25	
Gate-to-Source Forward Leakage	I _{GSS}	V _{GS} = -12V			-100	nA
Gate-to-Source Reverse Leakage		V _{GS} = 12V			100	
Total Gate Charge	Q _g	I _D = -2.3A		9.3	25	nC
Gate-to-Source Charge	Q _{gs}	V _{Ds} = -10V		1.6		
Gate-to-Drain ("Miller") Charge	Q _{gd}	V _{GS} = -10V *		3.0		
Turn-On Delay Time	t _{d(on)}	V _{DD} = -10V		12	40	ns
Rise Time	t _r	I _D = -1.0A		16	40	
Turn-Off Delay Time	t _{d(off)}	R _G = 6 Ω		42	90	
Fall Time	t _f	R _D = 10 Ω *		30	50	
Internal Source Inductance	L _s	Between lead, 6mm(0.25in.) from package and center of die contact		4.0		nH
Internal Drain Inductance	L _d			6.0		
Input Capacitance	C _{iss}	V _{GS} = 0V		290		pF
Output Capacitance	C _{oss}	V _{Ds} = -15V		210		
Reverse Transfer Capacitance	C _{rss}	f = 1.0MHz		67		
Continuous Source Current (Body Diode)	I _s	MOSFET symbol showing the integral reverse p-n junction diode.			-2.0	A
Pulsed Source Current (Body Diode) *2	I _{SM}				-9.2	
Diode Forward Voltage	V _{sd}	T _J = 25°C, I _s = -1.5A, V _{GS} = 0V*1			-1.2	V
Reverse Recovery Time	t _{rr}	T _J = 25°C, I _F = -1.5A		69	100	ns
Reverse Recovery Charge	Q _{rr}	d _i /d _t = -100A/ μ s*1		90	140	μ C

*1 Pulse width ≤ 300 μ s; duty cycle ≤ 2%.

*2 Repetitive rating; pulse width limited by max. junction temperature.